

**N-Channel MOSFET** 

## **General Description**

The WSD4070DN33 is the highest performance trench N-Channel MOSFETs with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The WSD4070DN33 meet the RoHS and Green Product requirement, 100%  $E_{AS}$  guaranteed with full function reliability approved.

#### **Features**

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% E<sub>AS</sub> Guaranteed
- Green Device Available

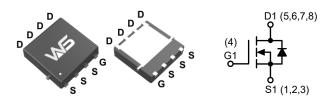
## **Product Summery**

BV <sub>DSS</sub>	R <sub>DS(ON)</sub>	I <sub>D</sub>	
40V	4.5mΩ	68A	

## **Applications**

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

#### **DFN3X3-8L Pin Configuration**



## **Absolute Maximum Ratings**

Symbol	Parameter	Rating	Units	
V <sub>DS</sub>	Drain-Source Voltage	40	V	
$V_{GS}$	Gate-Source Voltage	±20	V	
I <sub>D</sub> @T <sub>C</sub> =25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>7</sup>	68		
I <sub>D</sub> @T <sub>C</sub> =100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>7</sup>	35	A	
I <sub>DM</sub> @T <sub>C</sub> =25°C	Pulsed Drain Current <sup>3</sup>	144		
E <sub>AS</sub>	Avalanche Energy, Single Pulse (L=0.3mH)	80	mJ	
I <sub>AS</sub>	Avalanche Current	40	А	
P <sub>D</sub> @T <sub>A</sub> =25°C	Total Power Dissipation <sup>1</sup>	3.1	10/	
P <sub>D</sub> @T <sub>A</sub> =70°C	Total Power Dissipation <sup>1</sup>	2.0	W	
T <sub>STG</sub>	Storage Temperature Range -55 to 150		°C	
T <sub>J</sub>	Operating Junction Temperature Range	-55 to 150	C	

#### **Thermal Data**

Symbol	Parameter	Тур.	Max.	Units	
$R_{ heta JA}$	Thermal Resistance, Junction-to-Ambient <sup>1</sup>	nal Resistance, Junction-to-Ambient <sup>1</sup>		°C/W	
$R_{ heta JC}$	Thermal Resistance, Junction-to-Case <sup>1</sup>		2.8	C/VV	



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## **Electrical Characteristics** (T<sub>.1</sub>=25°C, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units	
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250μA	40			V	
D	Static Project Course On Besistance 2	V <sub>GS</sub> =10V , I <sub>D</sub> =7A		4.5	5.5	mΩ	
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =4.5V , I <sub>D</sub> =5A		5.3	7.6		
V <sub>GS(th)</sub>	Gate Threshold Voltage	\/ -\/   -250\	1.4	1.9	2.4	V	
$\Delta V_{GS(th)}$	V <sub>GS(th)</sub> Temperature Coefficient	- V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250μA		-6.06		mV/°C	
	Drain Source Leakage Current	V <sub>DS</sub> =40V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			2.0	μΑ	
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =40V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C			10		
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS}$ =±20V , $V_{DS}$ =0V			±100	nA	
9 <sub>fs</sub>	Forward Transconductance	V <sub>DS</sub> =5V , I <sub>D</sub> =20A		67		S	
$R_g$	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f = 1.0MHz		0.8	1.5	Ω	
$Q_g$	Total Gate Charge (10V)			28			
$Q_{gs}$	Gate-Source Charge	V <sub>DS</sub> =20V , V <sub>GS</sub> =10V , I <sub>DS</sub> =20A		3.9		nC	
$Q_{gd}$	Gate-Drain Charge			6.0		1	
$T_{d(on)}$	Turn-On Delay Time			7.2			
T <sub>r</sub>	Rise Time	V <sub>DS</sub> =20V , V <sub>GS</sub> =10V ,		3.0			
T <sub>d(off)</sub>	Turn-Off Delay Time	$R_G=3\Omega$ , $R_L=1\Omega$		23		ns	
T <sub>f</sub>	Fall Time			3.5			
C <sub>iss</sub>	Input Capacitance			2420			
C <sub>oss</sub>	Output Capacitance	V <sub>DS</sub> =20V , V <sub>GS</sub> =0V , f = 1.0MHz		220		pF	
C <sub>rss</sub>	Reverse Transfer Capacitance			150			

#### Note:

- 1. The value of  $R_{\theta JA}$  is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with  $T_A$ =25°C. The Power dissipation  $P_{DSM}$  is based on  $R_{\theta JA}$  t≤10s and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 150°C may be u sed if the PCB allows it.
- 2. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- 3. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}$ =150°C. Ratings are based on low frequency and duty cycles to keep initial  $T_J$ =25°C.
- 4. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.
- 5. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.
- 6. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150°C. The SOA curve provides a single pulse rating.
- 7. The maximum current rating is package limited.
- 8. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C.



# **Typical Characteristics**

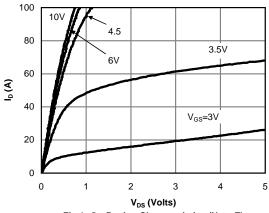


Fig 1: On-Region Characteristics (Note E)

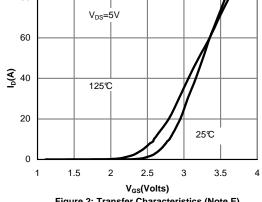


Figure 2: Transfer Characteristics (Note E)

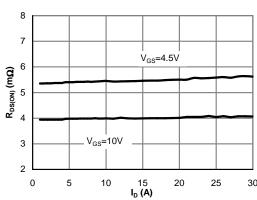


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

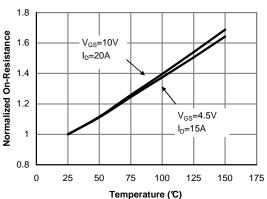


Figure 4: On-Resistance vs. Junction Tempgerature (Note E)

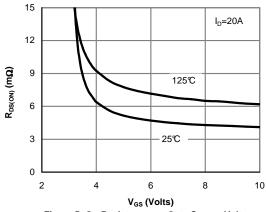


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

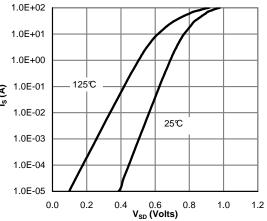
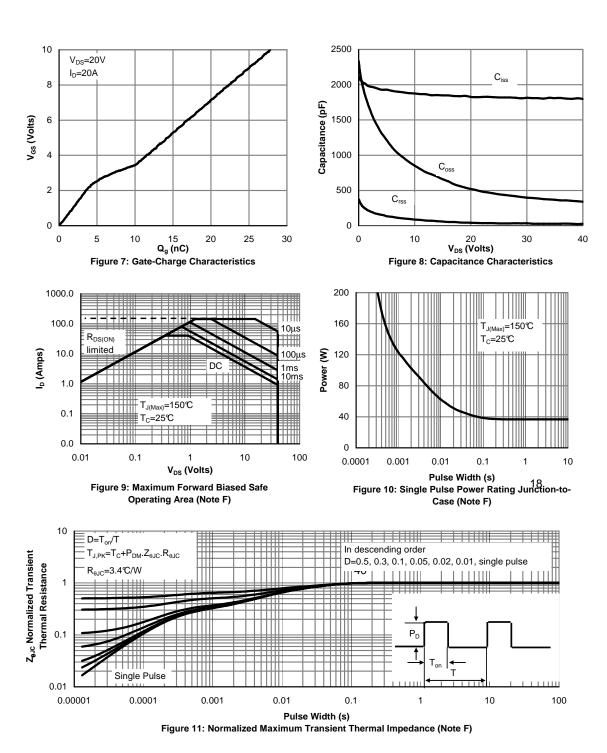


Figure 6: Body-Diode Characteristics (Note E)



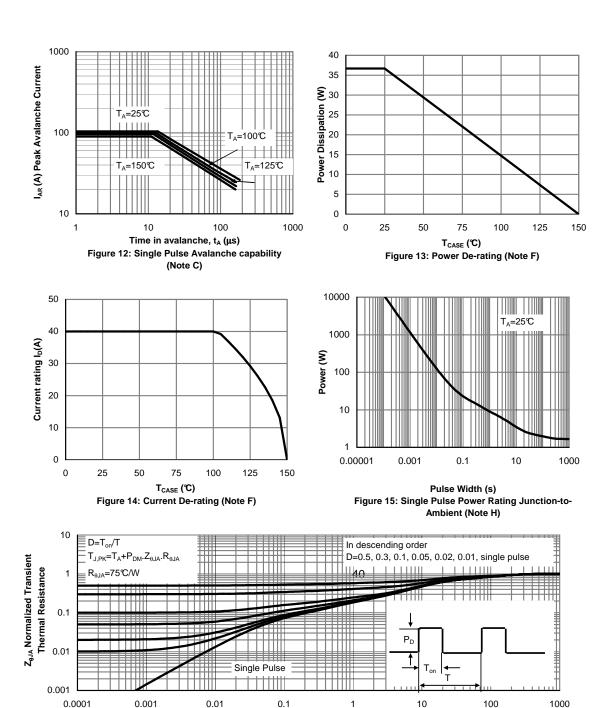
# **Typical Characteristics (Cont.)**



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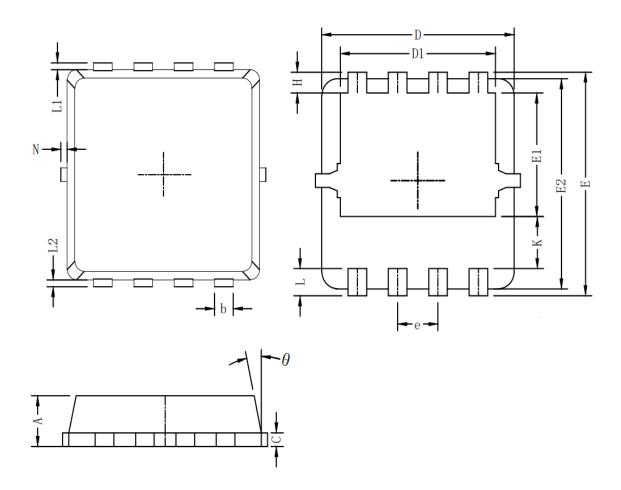
# **Typical Characteristics (Cont.)**



Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)



# **Packaging information**



Symbol	Dim in mm			
Symbol	min	typ	max	
А	0.6	0.75	0.9	
b	0.2	0.3	0.4	
С	0.15	0.2	0.25	
D	3	3.1	3.2	
D1	2.3	2.45	2.6	
E	3.15	3.3	3.45	
E1	1.43	1.73	1.93	
E2	2.9	3.05	3.2	
е	0.65BSC			
Н	0.2	0.35	0.5	
K	0.57	0.77	0.87	
L	0.3	0.4	0.5	
L1/L2	0.1REF			
θ	8°	10°	13°	
N	0		0.15	



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